



YOUSHANG SEMICONDUCTOR

设计研发新型功率器件

各类小信号开关

中低压及高压大电流等场效应管

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企业微信二维码



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Product Summary

BV_{DSS}	$R_{DS(ON)}$ Max	I_D Max $T_A = +25^\circ C$
-20V	160m Ω @ $V_{GS} = -4.5V$	-2.4A
	210m Ω @ $V_{GS} = -2.5V$	-2.1A

Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- ESD Protected Gate

Description and Applications

This MOSFET is designed to minimize the on-state resistance ($R_{DS(ON)}$) yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

- Backlighting
- Power management functions
- DC-DC converters
- Motor controls

Mechanical Data

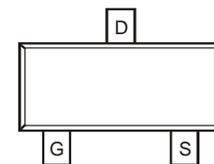
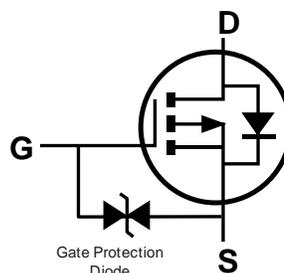
- Package: SOT23
- Package Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish – Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 e3
- Terminals Connections: See Diagram Below
- Weight: 0.009 grams (Approximate)



SOT23 (Standard)



Top View



Top View

Maximum Ratings (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V_{DSS}	-20	V
Gate-Source Voltage			V_{GSS}	± 12	V
Continuous Drain Current (Note 5) $V_{GS} = -4.5\text{V}$	Steady State	$T_A = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	I_D	-2.4 -1.9	A
Maximum Continuous Body Diode Forward Current (Note 5)			I_S	-1.12	A
Pulsed Drain Current (10 μs Pulse, Duty Cycle = 1%)			I_{DM}	-8	A

Thermal Characteristics

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 6)		P_D	0.84	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{\theta JA}$	150	$^\circ\text{C/W}$
Total Power Dissipation (Note 5)		P_D	1.40	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{\theta JA}$	91	$^\circ\text{C/W}$
Operating and Storage Temperature Range		T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

Notes: 5. Device mounted on 1" x 1" FR-4 PCB with high coverage 2oz. copper, single sided.
 6. Device mounted on FR-4 PCB, with minimum recommended pad layout.

Electrical Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV_{DSS}	-20	—	—	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current ($T_J = +25^\circ\text{C}$)	I_{DSS}	—	—	-10	μA	$V_{DS} = -16V, V_{GS} = 0V$
Gate-Source Leakage	I_{GSS}	—	—	± 10	μA	$V_{GS} = \pm 10V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	$V_{GS(TH)}$	-0.3	-0.6	-1.0	V	$V_{DS} = V_{GS}, I_D = -250\mu A$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	—	136	160	m Ω	$V_{GS} = -4.5V, I_D = -1.0A$
			183	210		$V_{GS} = -2.5V, I_D = -1.0A$
			229	298		$V_{GS} = -1.8V, I_D = -0.2A$
Diode Forward Voltage	V_{SD}	—	-0.8	-1.2	V	$V_{GS} = 0V, I_S = -1.0A$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C_{iss}	—	156	—	pF	$V_{DS} = -6V, V_{GS} = 0V$ $f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	—	36	—	pF	
Reverse Transfer Capacitance	C_{rss}	—	28	—	pF	
Gate Resistance	R_g	—	41	—	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1\text{MHz}$
Total Gate Charge ($V_{GS} = -4.5V$)	Q_g	—	1.6	—	nC	$V_{DS} = -6V$ $I_D = -2.2A$
Total Gate Charge ($V_{GS} = -10V$)	Q_g	—	3.4	—	nC	
Gate-Source Charge	Q_{gs}	—	0.3	—	nC	
Gate-Drain Charge	Q_{gd}	—	0.4	—	nC	
Turn-On Delay Time	$t_{D(ON)}$	—	3.2	—	ns	$V_{DS} = -6V, V_{GS} = -4.5V$ $R_{GEN} = 6\Omega, I_D = -1A$
Turn-On Rise Time	t_R	—	7.4	—	ns	
Turn-Off Delay Time	$t_{D(OFF)}$	—	11.0	—	ns	
Turn-Off Fall Time	t_F	—	10.5	—	ns	
Reverse Recovery Time	t_{RR}	—	6.5	—	ns	
Reverse Recovery Charge	Q_{RR}	—	0.8	—	nC	$I_F = -1.0A, dI/dt = 100A/\mu s$

Notes: 7. Short duration pulse test used to minimize self-heating effect.
8. Guaranteed by design. Not subject to product testing.

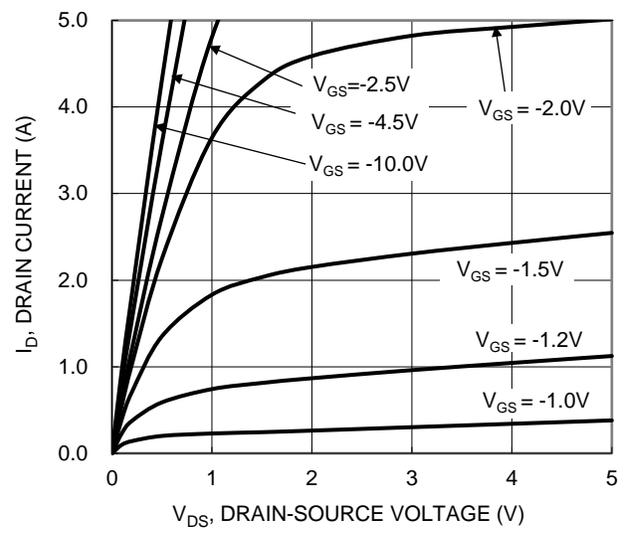


Figure 1. Typical Output Characteristic

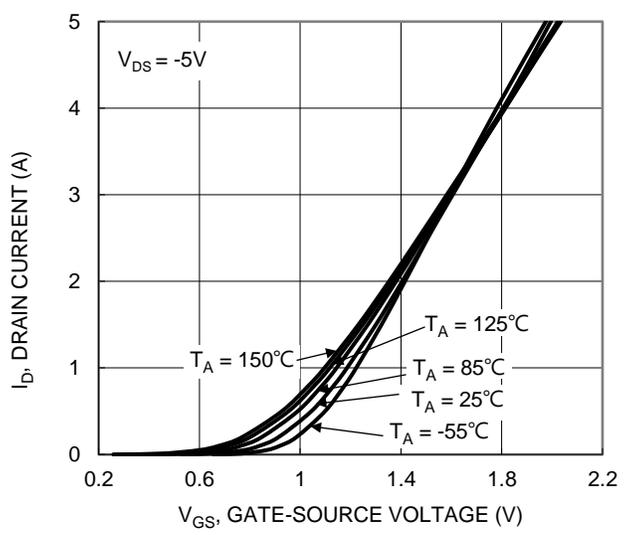


Figure 2. Typical Transfer Characteristic

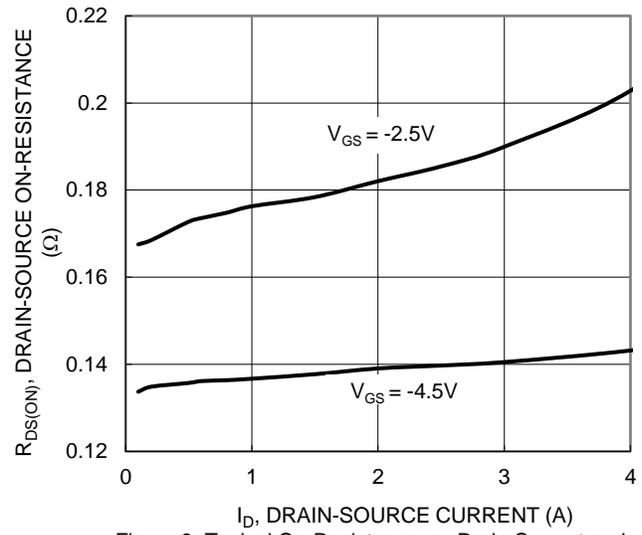


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

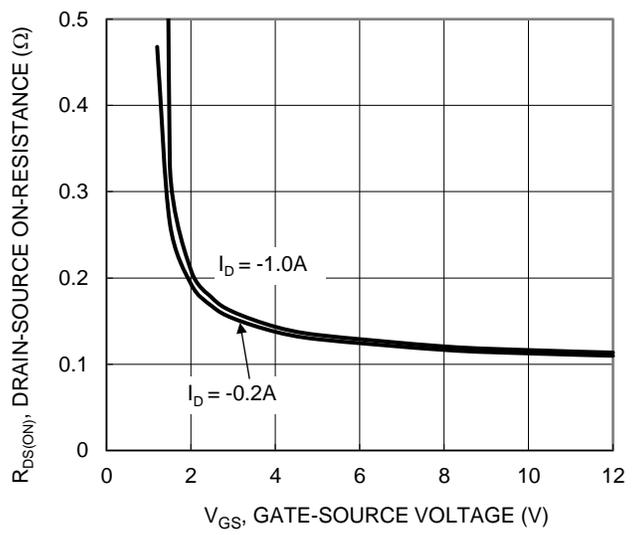


Figure 4. Typical Transfer Characteristic

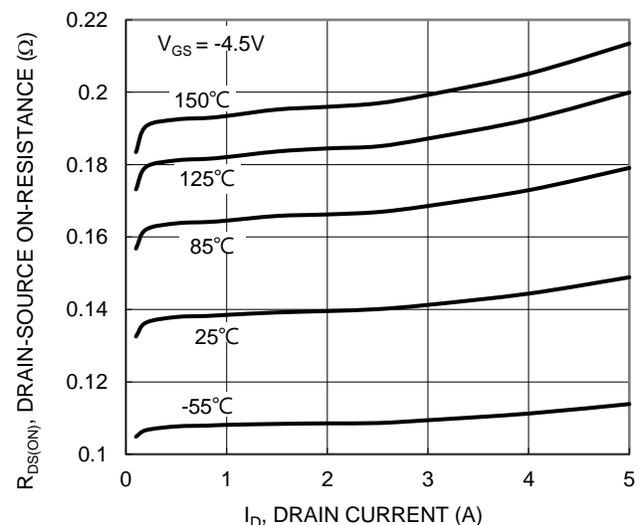


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature

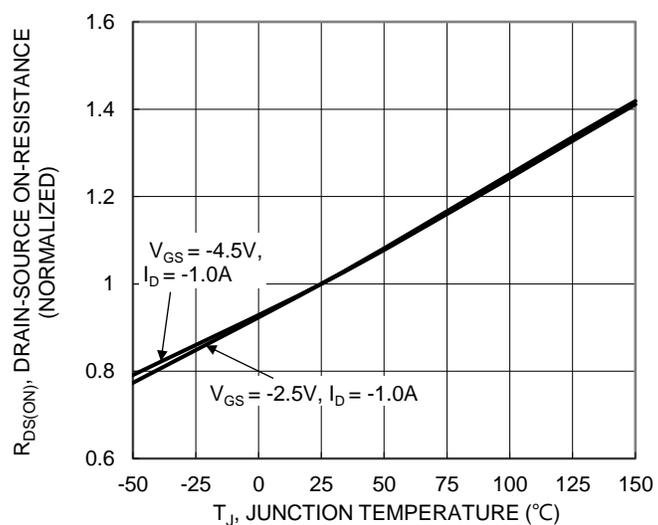
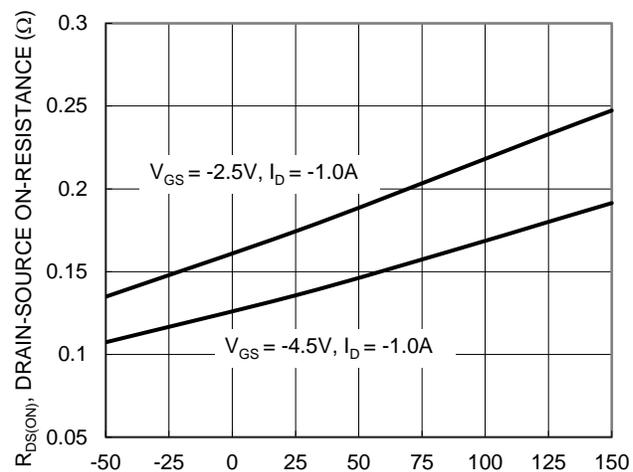
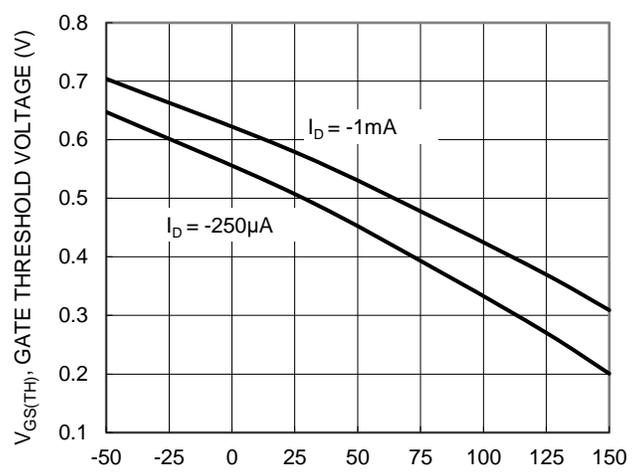


Figure 6. On-Resistance Variation with Junction Temperature



T_J , JUNCTION TEMPERATURE ($^{\circ}\text{C}$)
Figure 7. On-Resistance Variation with Junction Temperature



T_J , JUNCTION TEMPERATURE ($^{\circ}\text{C}$)
Figure 8. Gate Threshold Variation vs. Junction Temperature

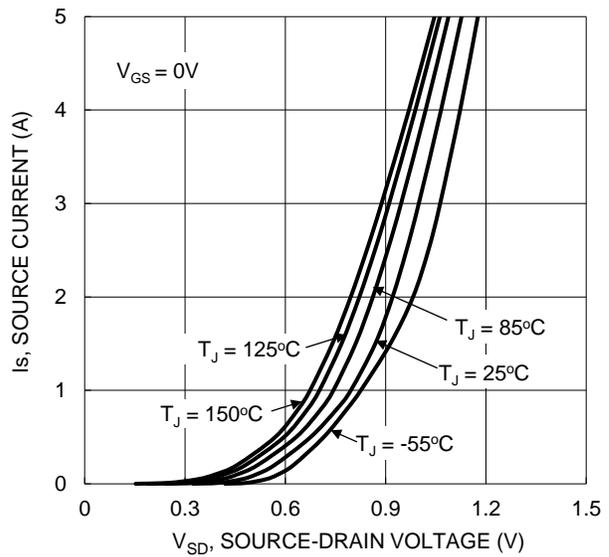


Figure 9. Diode Forward Voltage vs. Current

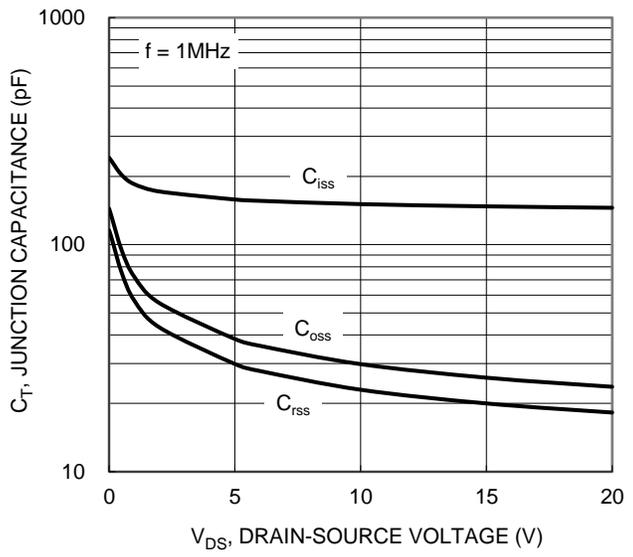


Figure 10. Typical Junction Capacitance

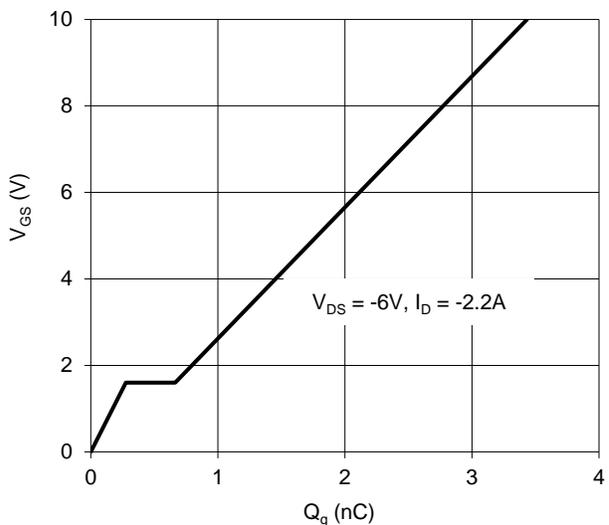


Figure 11. Gate Charge

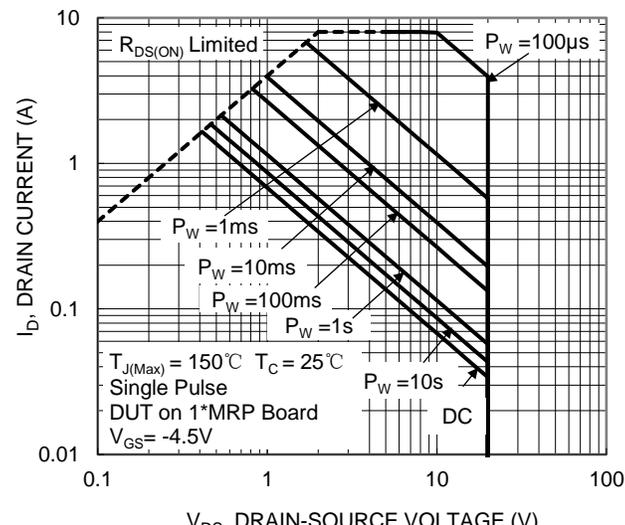


Figure 12. SOA, Safe Operation Area

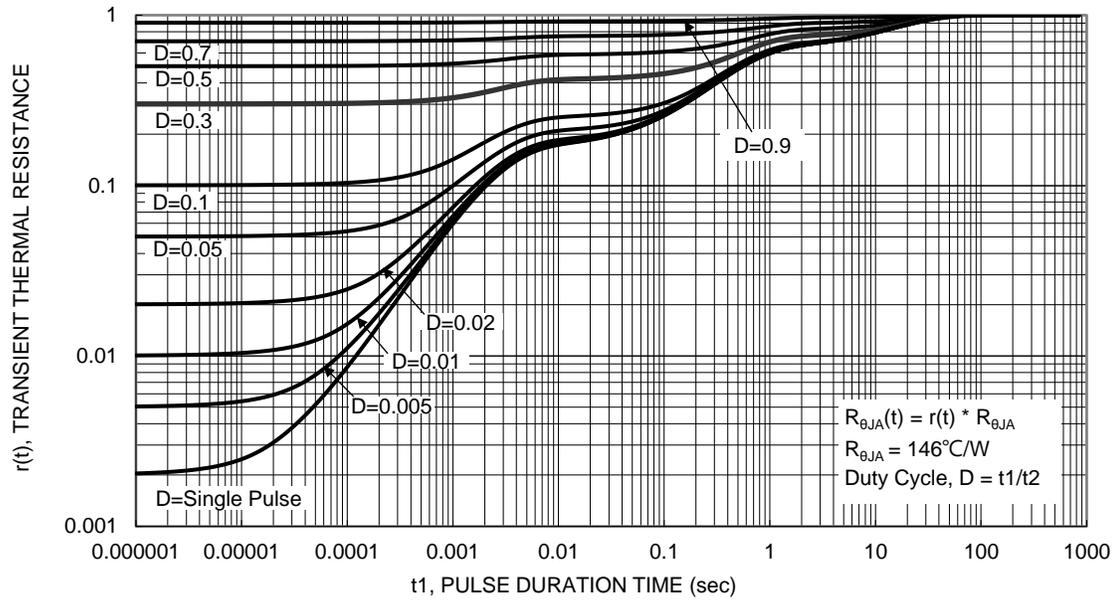
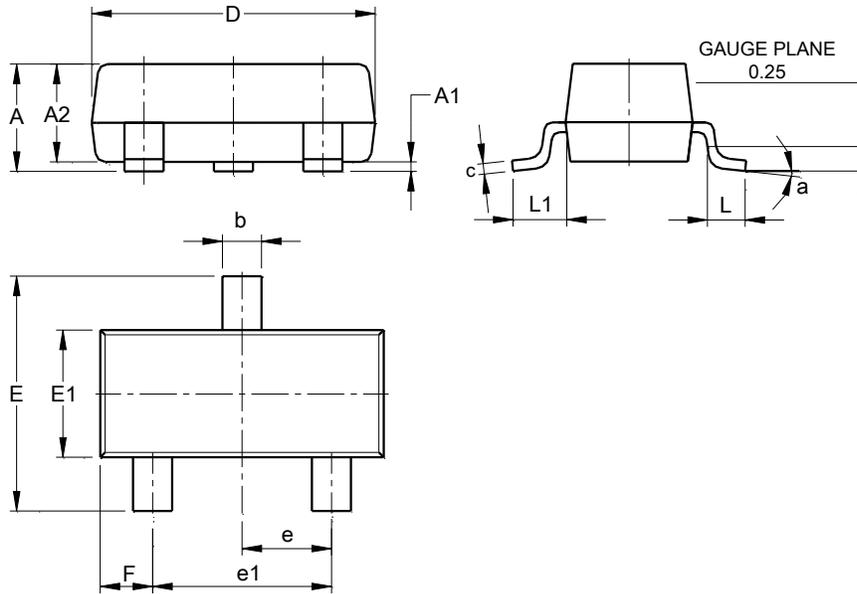


Figure 13. Transient Thermal Resistance

Package Outline Dimensions

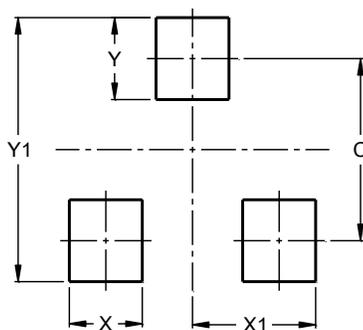
SOT23 (Standard)



SOT23 (Standard)			
Dim	Min	Max	Typ
A	0.90	1.15	1.025
A1	0.00	0.10	0.05
A2	0.85	1.10	0.975
b	0.30	0.51	0.40
c	0.080	0.202	0.11
D	2.80	3.00	2.90
E	2.25	2.55	2.40
E1	1.20	1.40	1.30
e	0.89	1.03	0.915
e1	1.78	2.05	1.83
F	0.40	0.60	0.535
L1	0.45	0.61	0.55
L	0.25	0.55	0.40
a	0°	8°	--
All Dimensions in mm			

Suggested Pad Layout

SOT23 (Standard)



Dimensions	Value (in mm)
C	2.0
X	0.8
X1	1.35
Y	0.9
Y1	2.9